

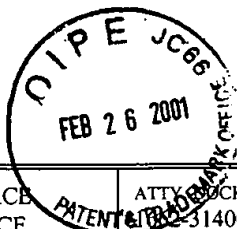
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FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary) (37 CFR 1.98(b))	PATENT NO. 1662-31400 (P00-3212)	SERIAL NO. 09/651,000
	APPLICANTS Michael S. BERTONE et al.	
	FILING DATE August 31, 2000	GROUP 2151

U. S. PATENT DOCUMENTS													
Examiner Initial		Patent Number							Issue Date	Patentee	Class	Sub-class	Filing Date (If Appropriate)
DN	AA	5	2	6	1	0	6	6	11/09/93	Jouppi et al.	395	425	03/27/90
	AB	5	3	1	7	7	1	8	05/31/94	Jouppi	395	425	01/25/93
	AC	5	7	5	8	1	8	3	05/26/98	Scales	395	825	07/17/96
	AD	5	7	6	1	7	2	9	06/02/98	Scales	711	148	07/17/96
	AE	5	7	8	7	4	8	0	07/28/98	Scales et al.	711	148	07/17/96
	AF	5	8	0	2	5	8	5	09/01/98	Scales et al.	711	154	07/17/96
	AG	5	8	0	9	4	5	0	09/15/98	Chrysos et al.	702	186	11/26/97
	AH	5	8	7	5	1	5	1	02/23/99	Mick	365	233	05/28/97
	AI	5	8	9	0	2	0	1	03/30/99	McLellan et al.	711	108	07/01/97
	AJ	5	8	9	3	9	3	1	04/13/99	Peng et al.	711	206	01/15/97
	AK	5	9	1	8	2	5	0	06/29/99	Hammond	711	205	05/05/95
	AL	5	9	1	8	2	5	1	06/29/99	Yamada et al.	711	207	12/23/96
	AM	5	9	2	3	8	7	2	07/13/99	Chrysos et al.	395	591	11/26/97
	AN	5	9	5	0	2	2	8	09/07/99	Scales et al.	711	148	02/03/97
	AO	5	9	6	4	8	6	7	10/12/99	Anderson et al.	712	219	11/26/97
	AP	5	9	8	3	3	2	5	11/09/99	Lewchuk	711	137	12/09/97
	AQ	6	0	0	0	0	4	4	12/07/99	Chrysos et al.	714	47	11/26/97
	AR	6	0	7	0	2	2	7	05/30/2000	Rokicki	711	117	10/31/97
DN	AS	6	0	8	5	3	0	0	07/04/2000	Sunaga et al.	711	168	09/19/97

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION													
		Document Number							Publication Date	Country or Patent Office	Class	Sub-Class	Translation
													Yes No



FORM PTO-1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. SCKET NO.	SERIAL NO.
		1662-31400 (P00-3212)	09/651,924
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT		FILING DATE	GROUP
(37 CFR 1.98(b))		August 31, 2000	2151

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OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)			
DN	AT	Alpha Architecture Reference Manual, Third Edition, The Alpha Architecture Committee, 1998 Digital Equipment Corporation (21 p.), in particular pages 3-1 through 3-15	
	AU	A Logic Design Structure For LSI Testability, E. B. Eichelberger et al., 1977 IEEE (Pages 462-468)	
	AV	Direct RDRAM™ 256/288-Mbit (512Kx16/18x32s), Preliminary Information Document DL0060 Version 1.01 (69 p.)	
	AW	Testability Features of AMD-K6™ Microprocessor, R. S. Fetherston et al., Advanced Micro Devices (8 p.)	
	AX	Hardware Fault Containment in Scalable Shared-Memory Multiprocessors, D. Teodosiu et al., Computer Systems Laboratory, Stanford University (12 p.), 1977	
	AY	Cellular Disco: resource management using virtual clusters on shared-memory multiprocessors, K. Govil et al., 1999 ACM 1-58113-140-2/99/0012 (16 p.)	
	AZ	Are Your PLDs Metastable?, Cypress Semiconductor Corporation, March 6, 1997 (19 p.)	
	BA	Rambus® RIMM™ Module (with 128/144Mb RDRAMs), Preliminary Information, Document DL0084 Version 1.1 (12 p.)	
	BB	Direct Rambus™ RIMM™ Module Specification Version 1.0, Rambus Inc., SL-0006-100 (32 p.), 2000	
DN	BC	End-To-End Fault Containment In Scalable Shared-Memory Multiprocessors, D. Teodosiu, July 2000 (148 p.)	
Examiner		Date Considered	
Indy Nguyen		11/13/03	
EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.			